

# Search Notes



Application/Control No.

10/821,486

Examiner

TAN TRINH

Applicant(s)/Patent under Reexamination

LAI, YHEAN-SEN

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
455	3.02	6/27/2007	TT
	12.1		
	562.1		
	13.3		
	142		
	313		
	324		
	323		
370	347		
	389		
375	326		
	344		
up class search		11/23/07	T.T.

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
2G-PUB TEXT SEARCH (SEE PRINT OUT)		11/23/07	T.T.

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	6/27/2000	
EAST	11/23/07	T.T.
INTERFERENCE SEARCH	11/23/07	T.T.